

Appendix D

Contour Plots

CDMA835 (1013CH) Slide down

DUT: TXT8045US; Type: Slide down; Serial: #1

Communication System: CDMA 835MHz FCC; Frequency: 824.7 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn466; Calibrated: 2011-03-01
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DAS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -33.2 dB A/m

Location: -14, -1.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 28.0 dB

ABM1 comp = -5.17 dB A/m

BWC Factor = 0.151969 dB

Location: -14, -1.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -5.17 dB A/m

BWC Factor = 0.151969 dB

Location: -14, -1.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -34.1 dB A/m

Location: -0.5, 10, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 30.9 dB

ABM1 comp = -3.24 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 10, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -3.24 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 10, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 7.07 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 1.01 dB
BWC Factor = 10.8 dB
Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -37.2 dB A/m
Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.1 dB
ABM1 comp = 4.86 dB A/m
BWC Factor = 0.151969 dB
Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

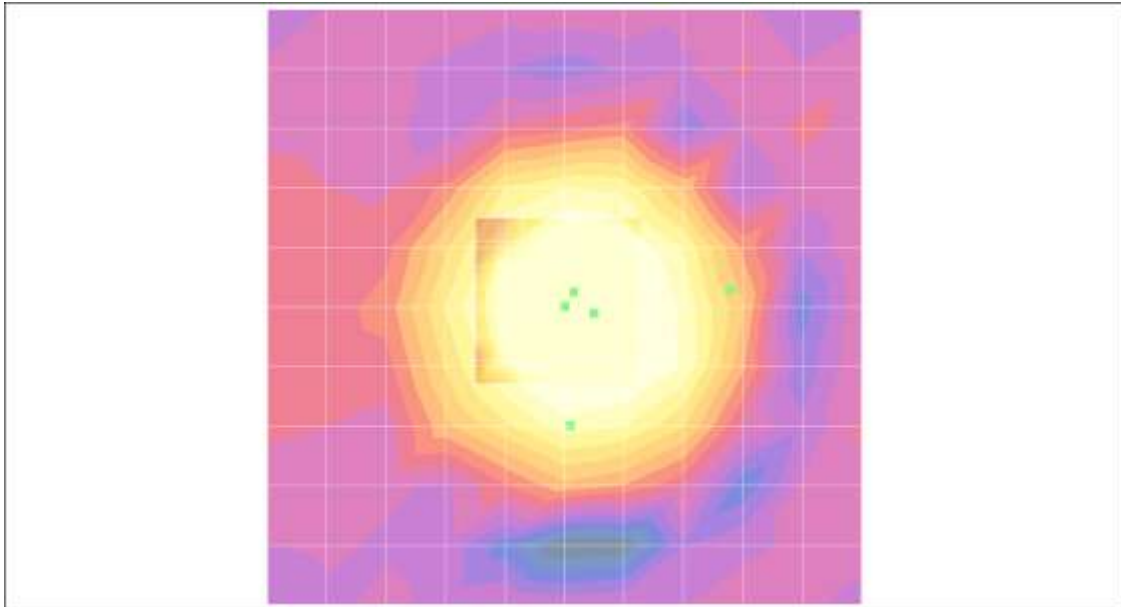
ABM1 comp = 4.86 dB A/m
BWC Factor = 0.151969 dB
Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.30 dB A/m
BWC Factor = 0.15103 dB
Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

CDMA835 (384CH) Slide down

DUT: TXT8045US; Type: Slide up; Serial: #1

Communication System: CDMA 835MHz FCC; Frequency: 836.52 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn466; Calibrated: 2011-03-01
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DAS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -34.7 dB A/m

Location: -14, 2.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 29.9 dB

ABM1 comp = -4.86 dB A/m

BWC Factor = 0.151969 dB

Location: -14, 2.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -4.86 dB A/m

BWC Factor = 0.151969 dB

Location: -14, 2.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -38.1 dB A/m

Location: -7.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 32.6 dB

ABM1 comp = -5.54 dB A/m

BWC Factor = 0.151969 dB

Location: -7.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -5.54 dB A/m

BWC Factor = 0.151969 dB

Location: -7.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.51 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -1.5, 363.7 mm

Point measurement/z (axial) 300–3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 1.25 dB
BWC Factor = 10.8 dB
Location: -0.8, 0.8, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -38.9 dB A/m
Location: -2.5, 2.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.6 dB
ABM1 comp = 3.65 dB A/m
BWC Factor = 0.151969 dB
Location: -2.5, 2.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

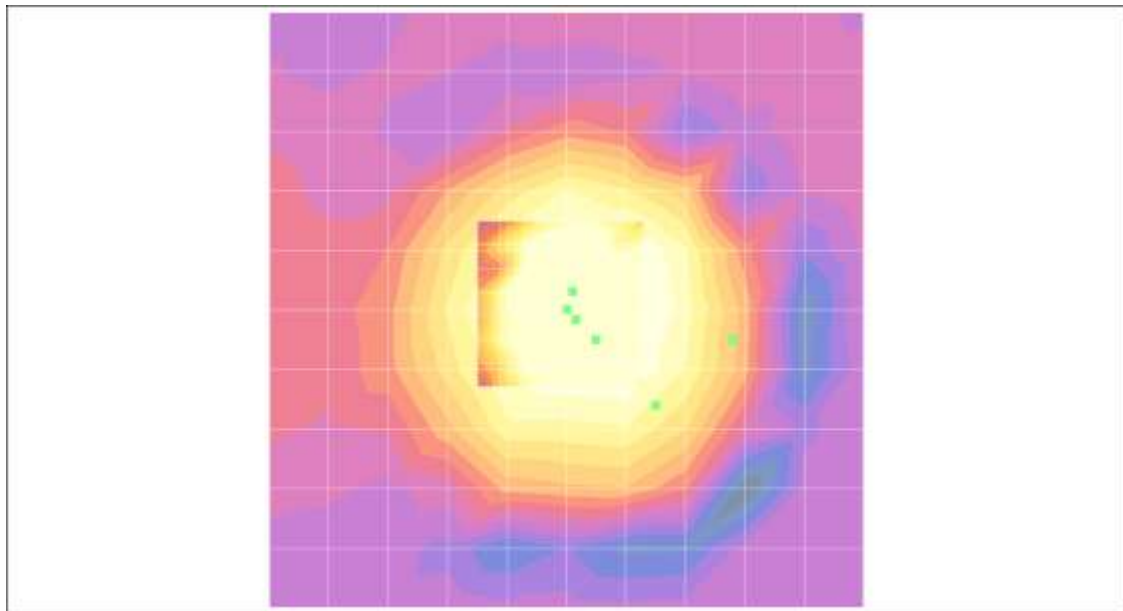
ABM1 comp = 3.65 dB A/m
BWC Factor = 0.151969 dB
Location: -2.5, 2.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 4.44 dB A/m
BWC Factor = 0.151969 dB
Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

CDMA835 (777CH) Slide down

DUT: TXT8045US; Type: Slide down; Serial: #1

Communication System: CDMA 835MHz FCC; Frequency: 848.31 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn466; Calibrated: 2011-03-01
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DAS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -28.6 dB A/m

Location: -5, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 23.7 dB

ABM1 comp = -4.92 dB A/m

BWC Factor = 0.151969 dB

Location: -5, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -4.92 dB A/m

BWC Factor = 0.151969 dB

Location: -5, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -35.4 dB A/m

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 33.2 dB

ABM1 comp = -2.25 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.25 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.30 dB A/m

BWC Factor = 0.15103 dB

Location: -1.5, -1.5, 363.7 mm

Point measurement/z (axial) 300–3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.815 dB

BWC Factor = 10.8 dB

Location: -3.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -39.4 dB A/m

Location: -5.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 41.8 dB

ABM1 comp = 2.36 dB A/m

BWC Factor = 0.151969 dB

Location: -5.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 2.36 dB A/m

BWC Factor = 0.151969 dB

Location: -5.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

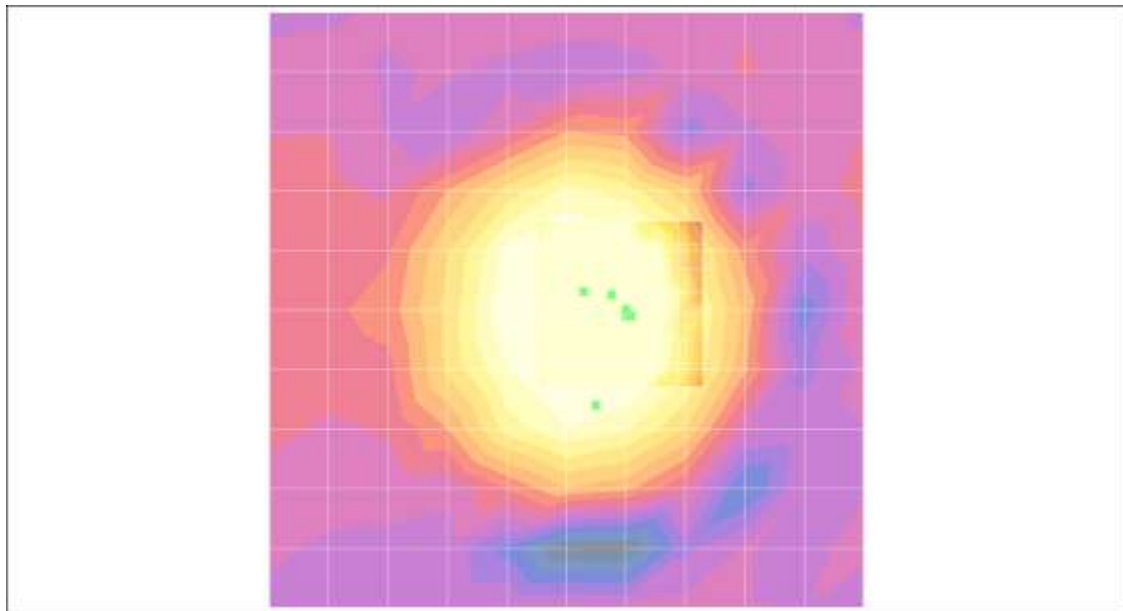
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 3.92 dB A/m

BWC Factor = 0.15103 dB

Location: -5, 0, 363.7 mm



0 dB = 1.00A/m

PCS1900 (25CH) Slide down

DUT: TXT8045US; Type: Slide down; Serial: #1

Communication System: PCS 1900MHz FCC; Frequency: 1851.25 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DASYS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn466; Calibrated: 2011-03-01
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DASYS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -33.2 dB A/m

Location: -12, 2.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 29.9 dB

ABM1 comp = -3.32 dB A/m

BWC Factor = 0.151969 dB

Location: -12, 2.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -3.32 dB A/m

BWC Factor = 0.151969 dB

Location: -12, 2.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -46.7 dB A/m

Location: -0.5, -7, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 41.3 dB

ABM1 comp = -5.41 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -7, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -5.41 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -7, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.76 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -1.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 1.07 dB
BWC Factor = 10.8 dB
Location: -0.8, 0.8, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -39.0 dB A/m
Location: -2.5, 2.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 43.9 dB
ABM1 comp = 4.91 dB A/m
BWC Factor = 0.151969 dB
Location: -2.5, 2.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

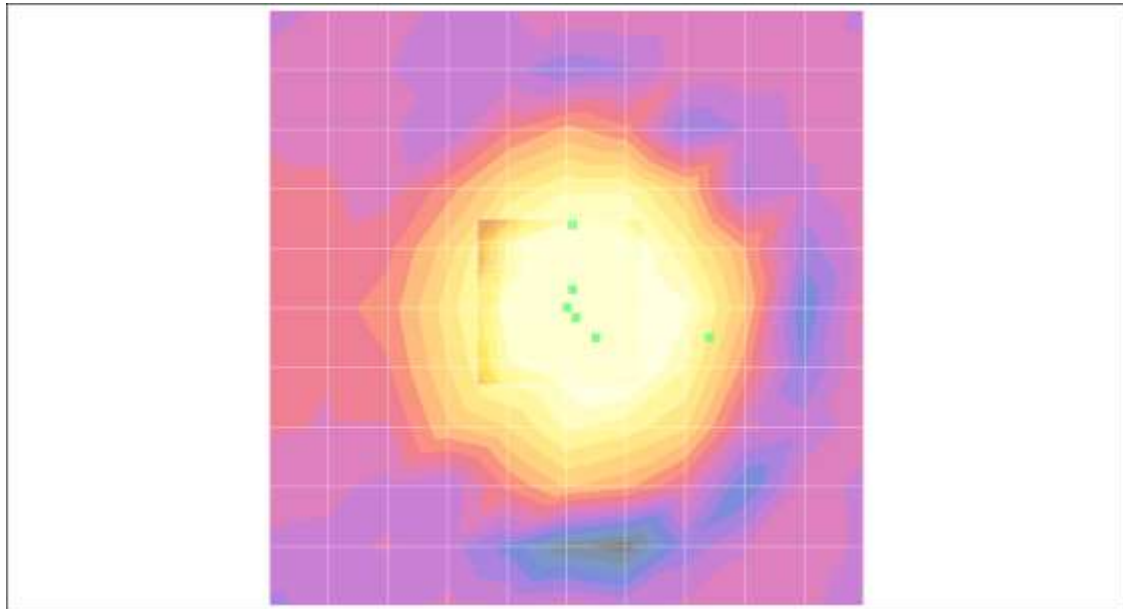
ABM1 comp = 4.91 dB A/m
BWC Factor = 0.151969 dB
Location: -2.5, 2.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 4.42 dB A/m
BWC Factor = 0.151969 dB
Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

PCS1900 (600CH) Slide down

DUT: TXT8045US; Type: Slide down; Serial: #1

Communication System: PCS 1900MHz FCC; Frequency: 1880 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DASYS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn466; Calibrated: 2011-03-01
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DASYS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -33.6 dB A/m

Location: -12, 2.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 30.4 dB

ABM1 comp = -3.23 dB A/m

BWC Factor = 0.15103 dB

Location: -12, 2.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -3.23 dB A/m

BWC Factor = 0.15103 dB

Location: -12, 2.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -48.0 dB A/m

Location: -4.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.7 dB

ABM1 comp = -5.26 dB A/m

BWC Factor = 0.15103 dB

Location: -4.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -5.26 dB A/m

BWC Factor = 0.15103 dB

Location: -4.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.62 dB A/m

BWC Factor = 0.151969 dB

Location: -1.5, 0.5, 363.7 mm

Point measurement/z (axial) 300–3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 1.45 dB
BWC Factor = 10.8 dB
Location: -1.8, 0.8, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -40.0 dB A/m
Location: -3.5, 2.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 44.9 dB
ABM1 comp = 4.92 dB A/m
BWC Factor = 0.15103 dB
Location: -3.5, 2.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

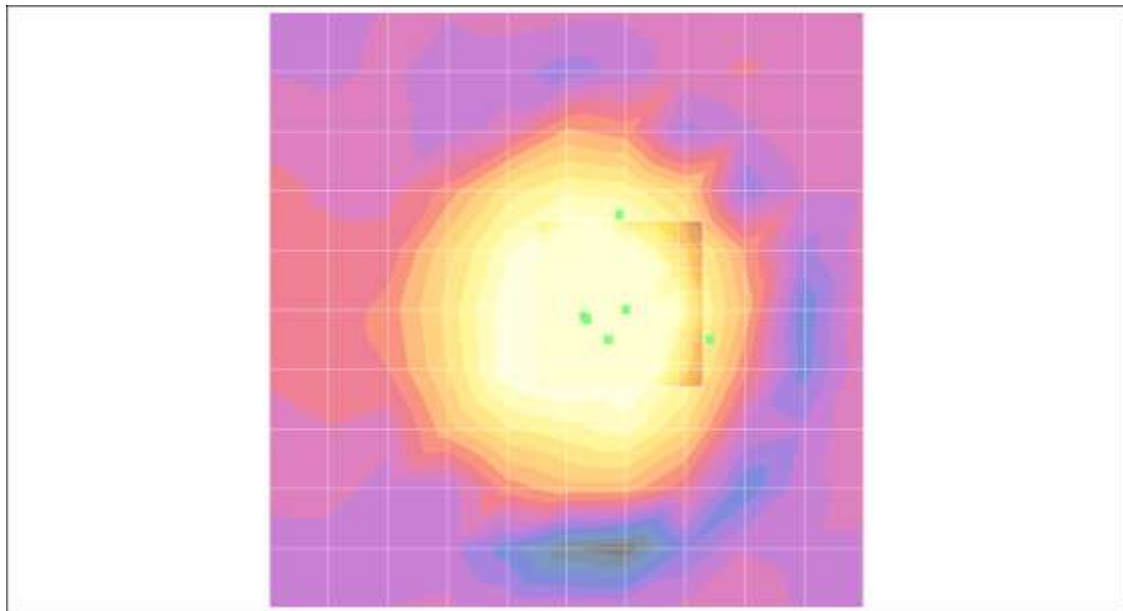
ABM1 comp = 4.92 dB A/m
BWC Factor = 0.15103 dB
Location: -3.5, 2.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.47 dB A/m
BWC Factor = 0.151969 dB
Location: -5, 0, 363.7 mm



0 dB = 1.00A/m

PCS1900 (1175CH) Slide down

DUT: TXT8045US; Type: Slide up; Serial: #1

Communication System: PCS 1900MHz FCC; Frequency: 1908.75 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn466; Calibrated: 2011-03-01
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -33.2 dB A/m

Location: -12, -1.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 30.4 dB

ABM1 comp = -2.76 dB A/m

BWC Factor = 0.151969 dB

Location: -12, -1.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.76 dB A/m

BWC Factor = 0.151969 dB

Location: -12, -1.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -39.4 dB A/m

Location: -7.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 34.0 dB

ABM1 comp = -5.38 dB A/m

BWC Factor = 0.151969 dB

Location: -7.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -5.38 dB A/m

BWC Factor = 0.151969 dB

Location: -7.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.47 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300–3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 1.09 dB
BWC Factor = 10.8 dB
Location: -2.8, 2.8, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -41.2 dB A/m
Location: -4.5, 4.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 43.7 dB
ABM1 comp = 2.52 dB A/m
BWC Factor = 0.151969 dB
Location: -4.5, 4.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

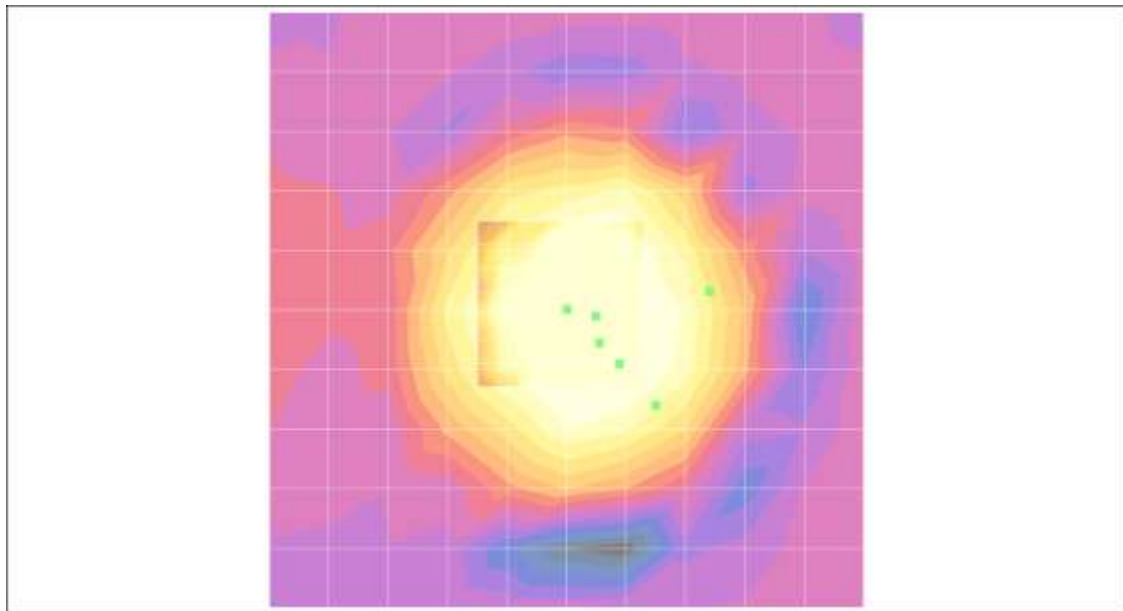
ABM1 comp = 2.52 dB A/m
BWC Factor = 0.151969 dB
Location: -4.5, 4.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 4.49 dB A/m
BWC Factor = 0.151969 dB
Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

CDMA835 (1013CH) Slide up

DUT: TXT8045US; Type: Slide up; Serial: #1

Communication System: CDMA 835MHz FCC; Frequency: 824.7 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn466; Calibrated: 2011-03-01
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DAS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -44.8 dB A/m

Location: -10, 2.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 41.3 dB

ABM1 comp = -3.41 dB A/m

BWC Factor = 0.151969 dB

Location: -10, 2.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -3.41 dB A/m

BWC Factor = 0.151969 dB

Location: -10, 2.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -47.0 dB A/m

Location: -1.5, 10, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.9 dB

ABM1 comp = -4.13 dB A/m

BWC Factor = 0.151969 dB

Location: -1.5, 10, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -4.13 dB A/m

BWC Factor = 0.151969 dB

Location: -1.5, 10, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.62 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) 300–3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 1.01 dB

BWC Factor = 10.8 dB

Location: 1.3, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -43.8 dB A/m

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 48.3 dB

ABM1 comp = 4.46 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 4.46 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

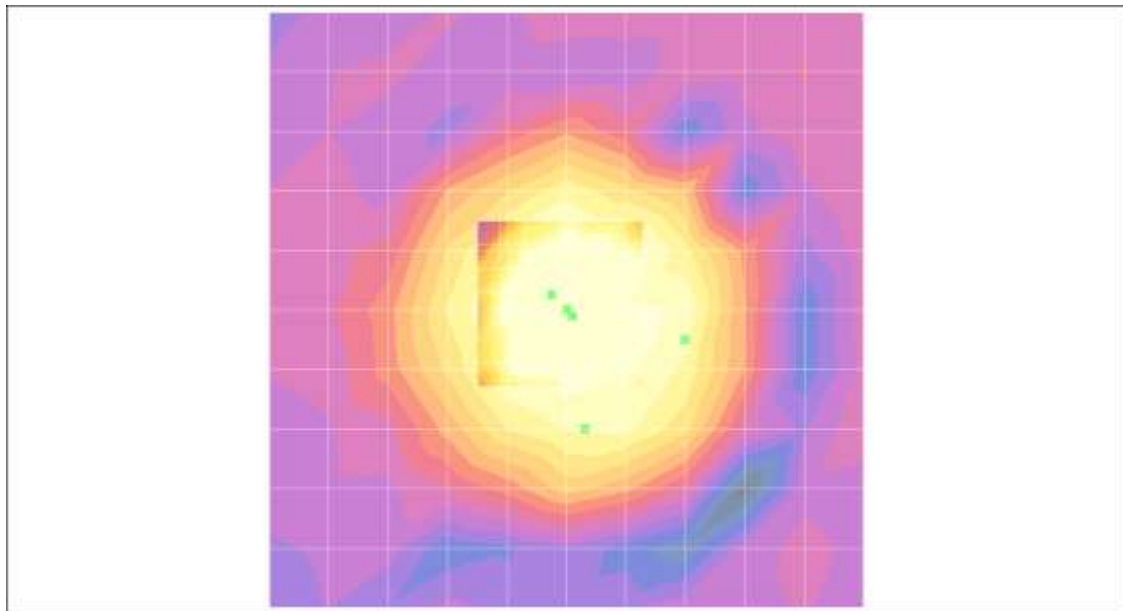
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 2.58 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

CDMA835 (384CH) Slide up

DUT: TXT8045US; Type: Slide up; Serial: #1

Communication System: CDMA 835MHz FCC; Frequency: 836.52 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn466; Calibrated: 2011-03-01
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DAS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -49.9 dB A/m

Location: -10, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 46.3 dB

ABM1 comp = -3.61 dB A/m

BWC Factor = 0.151969 dB

Location: -10, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -3.61 dB A/m

BWC Factor = 0.151969 dB

Location: -10, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -49.3 dB A/m

Location: 1.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 44.8 dB

ABM1 comp = -4.48 dB A/m

BWC Factor = 0.151969 dB

Location: 1.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -4.48 dB A/m

BWC Factor = 0.151969 dB

Location: 1.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 4.95 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 1.48 dB
BWC Factor = 10.8 dB
Location: -0.8, 0.8, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -50.6 dB A/m
Location: -2.5, 2.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 54.5 dB
ABM1 comp = 3.85 dB A/m
BWC Factor = 0.151969 dB
Location: -2.5, 2.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

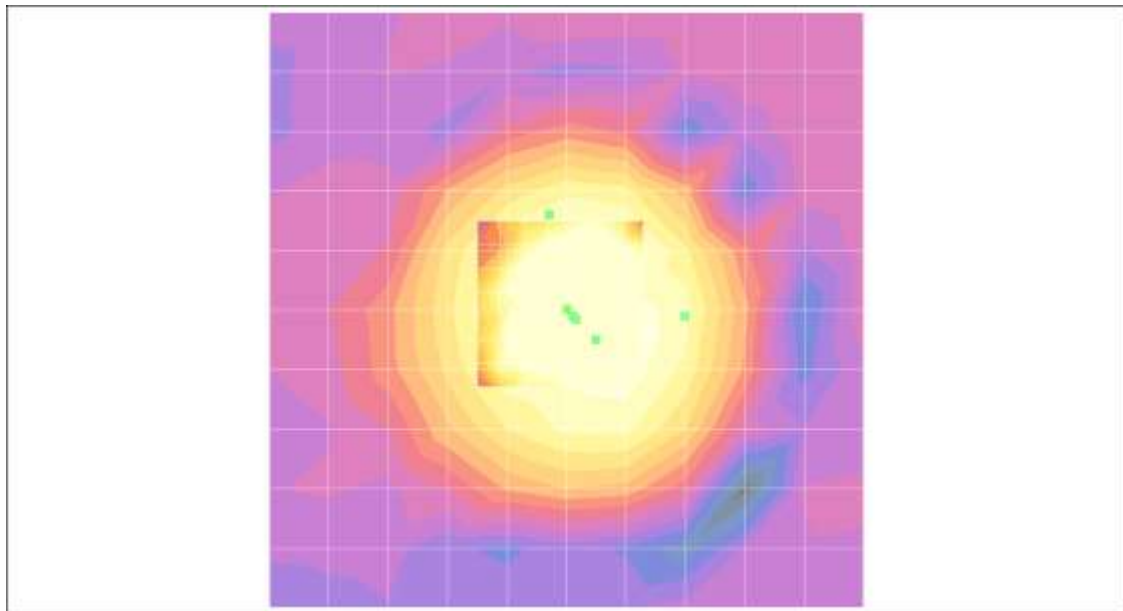
ABM1 comp = 3.85 dB A/m
BWC Factor = 0.151969 dB
Location: -2.5, 2.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 3.90 dB A/m
BWC Factor = 0.151969 dB
Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

CDMA835 (777CH) Slide up

DUT: TXT8045US; Type: Slide up; Serial: #1

Communication System: CDMA 835MHz FCC; Frequency: 848.31 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn466; Calibrated: 2011-03-01
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DAS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -44.3 dB A/m

Location: -10, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.3 dB

ABM1 comp = -2.09 dB A/m

BWC Factor = 0.151969 dB

Location: -10, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.09 dB A/m

BWC Factor = 0.151969 dB

Location: -10, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -47.5 dB A/m

Location: -4.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.9 dB

ABM1 comp = -4.58 dB A/m

BWC Factor = 0.151969 dB

Location: -4.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -4.58 dB A/m

BWC Factor = 0.151969 dB

Location: -4.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.42 dB A/m

BWC Factor = 0.15103 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) 300–3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 1.16 dB

BWC Factor = 10.8 dB

Location: 1.3, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -43.7 dB A/m

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 48.6 dB

ABM1 comp = 4.83 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 4.83 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

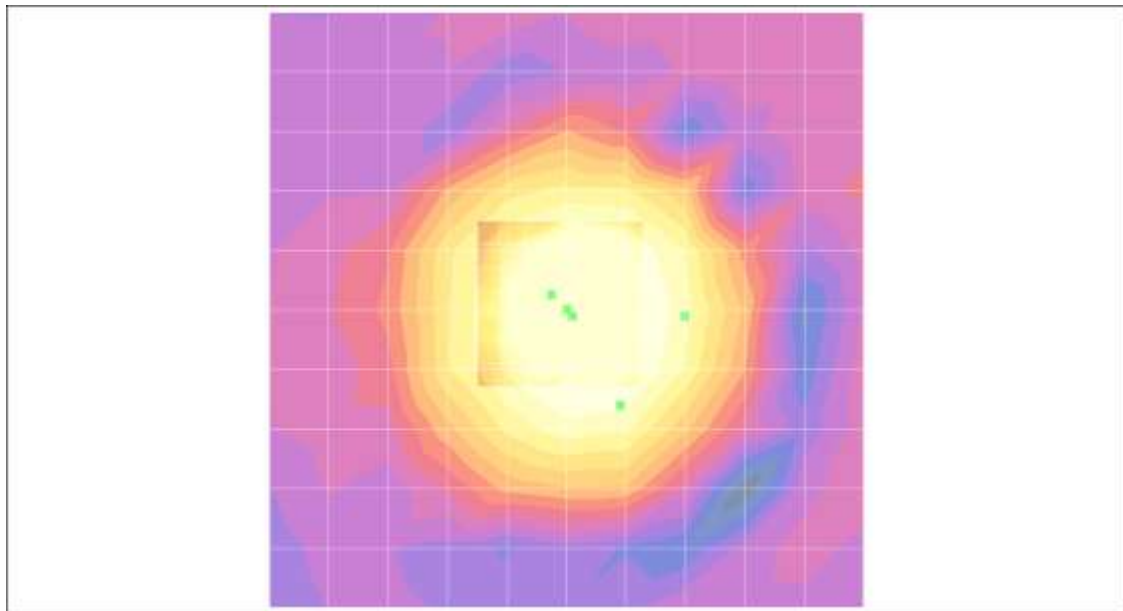
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 4.19 dB A/m

BWC Factor = 0.15103 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

PCS1900 (25CH) Slide up

DUT: TXT8045US; Type: Slide up; Serial: #1

Communication System: PCS 1900MHz FCC; Frequency: 1851.25 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DASYS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn466; Calibrated: 2011-03-01
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DASYS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -46.3 dB A/m

Location: -12, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 43.8 dB

ABM1 comp = -2.54 dB A/m

BWC Factor = 0.151969 dB

Location: -12, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.54 dB A/m

BWC Factor = 0.151969 dB

Location: -12, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -48.2 dB A/m

Location: -3.5, 6, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 44.9 dB

ABM1 comp = -3.26 dB A/m

BWC Factor = 0.151969 dB

Location: -3.5, 6, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -3.26 dB A/m

BWC Factor = 0.151969 dB

Location: -3.5, 6, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.08 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 1.18 dB

BWC Factor = 10.8 dB

Location: -2.7, -3.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -45.0 dB A/m

Location: -4.5, -1.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 49.7 dB

ABM1 comp = 4.72 dB A/m

BWC Factor = 0.151969 dB

Location: -4.5, -1.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 4.72 dB A/m

BWC Factor = 0.151969 dB

Location: -4.5, -1.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

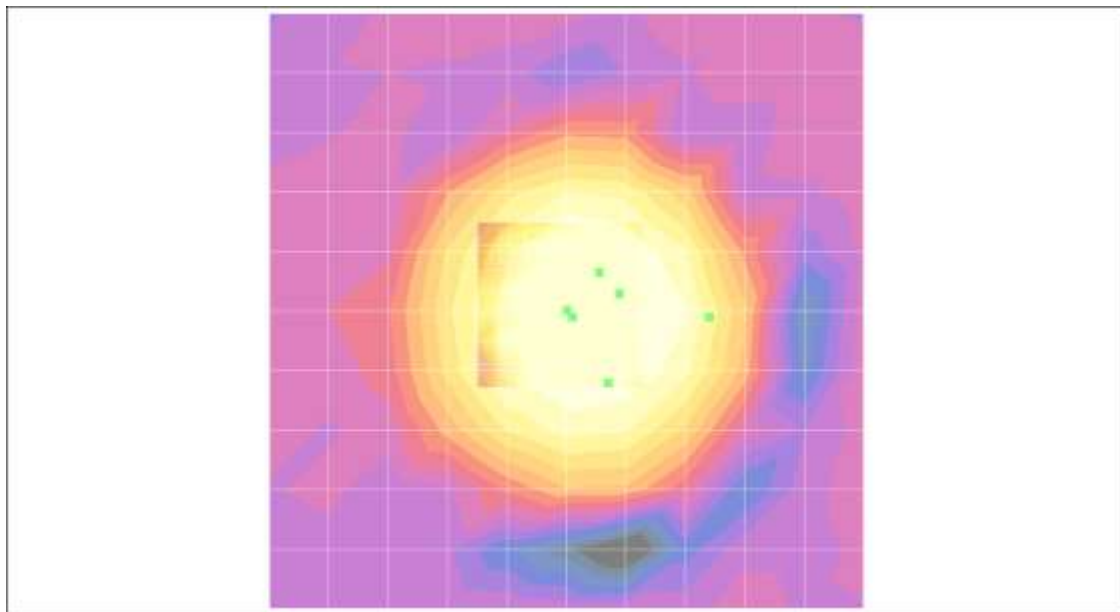
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 4.15 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

PCS1900 (600CH) Slide up

DUT: TXT8045US; Type: Slide up; Serial: #1

Communication System: PCS 1900MHz FCC; Frequency: 1880 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DASYS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn466; Calibrated: 2011-03-01
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DASYS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -46.5 dB A/m

Location: -12, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 41.1 dB

ABM1 comp = -5.36 dB A/m

BWC Factor = 0.151969 dB

Location: -12, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -5.36 dB A/m

BWC Factor = 0.151969 dB

Location: -12, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -48.3 dB A/m

Location: -3.5, 7, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 45.5 dB

ABM1 comp = -2.89 dB A/m

BWC Factor = 0.151969 dB

Location: -3.5, 7, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.89 dB A/m

BWC Factor = 0.151969 dB

Location: -3.5, 7, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.05 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) 300–3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 1.14 dB

BWC Factor = 10.8 dB

Location: -2.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -45.1 dB A/m

Location: -4.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 49.9 dB

ABM1 comp = 4.81 dB A/m

BWC Factor = 0.151969 dB

Location: -4.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 4.81 dB A/m

BWC Factor = 0.151969 dB

Location: -4.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

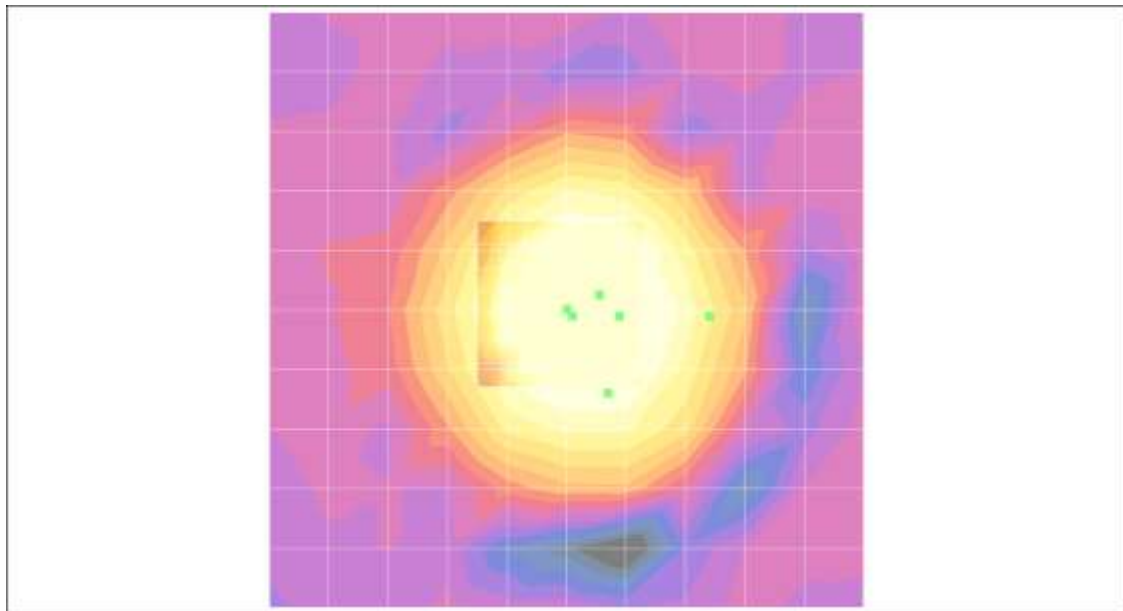
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.87 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

PCS1900 (1175CH) Slide up

DUT: TXT8045US; Type: Slide up; Serial: #1

Communication System: PCS 1900MHz FCC; Frequency: 1908.75 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE3 Sn466; Calibrated: 2011-03-01
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DAS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -45.7 dB A/m

Location: -10, 2.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 41.8 dB

ABM1 comp = -3.92 dB A/m

BWC Factor = 0.151969 dB

Location: -10, 2.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -3.92 dB A/m

BWC Factor = 0.151969 dB

Location: -10, 2.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -48.3 dB A/m

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 45.1 dB

ABM1 comp = -3.21 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -3.21 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.64 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 2.5, 363.7 mm

Point measurement/z (axial) 300–3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.872 dB

BWC Factor = 10.8 dB

Location: -2.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -26.1 dB A/m

Location: -4.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 30.9 dB

ABM1 comp = 4.78 dB A/m

BWC Factor = 0.151969 dB

Location: -4.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 4.78 dB A/m

BWC Factor = 0.151969 dB

Location: -4.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

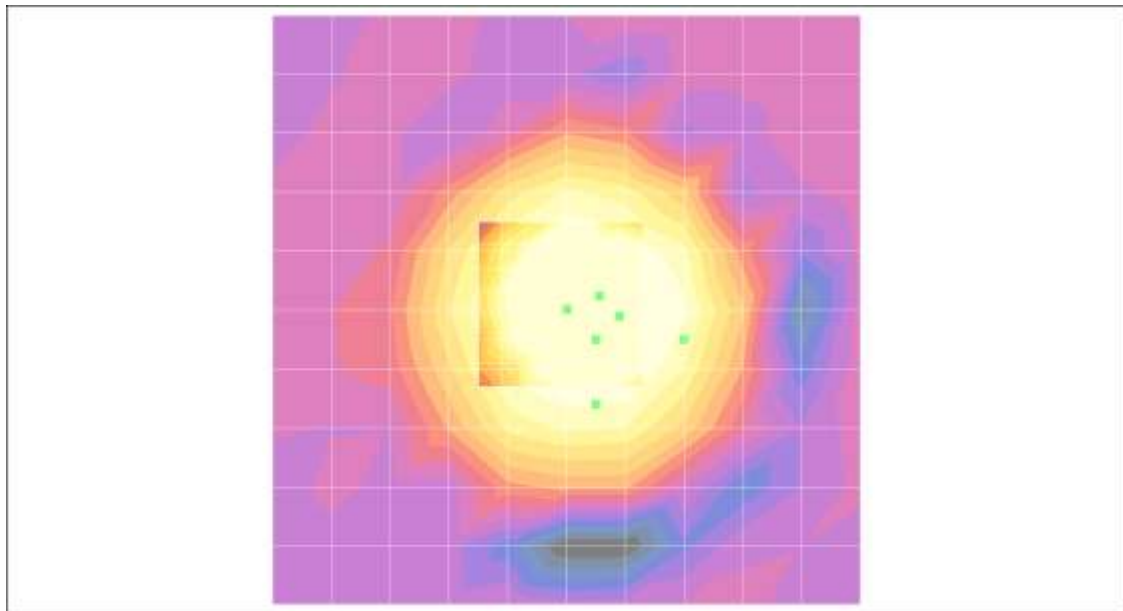
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 4.35 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m